

Enabling precision coordinate metrology for universal optical testing and alignment applications (Erratum)

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This article [*Opt. Eng.* 60(3), 035106 (15 March 2021) <https://doi.org/10.1117/1.OE.60.3.035106>] was originally published with an error in Fig. 56. The RMS error units in parts (a) and (b) were in “nm” instead of “ μm .” The paper was corrected on 7 April 2021.

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